Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/033,746	CHAN ET AL.	
Examiner	Art Unit	
Isaac M. Woo	2166	

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Class	Subclass	Date	Examiner
· 707	100-104.1	1/11/2007	IW
715	517-530	1/11/2007	IW

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			-
PGPUB&USPAT - text search - See history search printout(s)		1/11/2007	IW

SEARCH NO (INCLUDING SEARCH		)
,	DATE	EXMR
See search history printout(s), ACM, IEEE, Google	1/11/2007	IW
Consulted with Tod Swan for 101 issue, No 101 problem	1/11/2007	IW
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